Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/767,219	WAN ET AL.
Examiner	Art Unit
Y Quach Lee	2875

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	Updated Search	6/21/2005	YMY

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

RCH STRATEGY	<u>') </u>
DATE	EXMR
6/21/2005	YMY
:	
	DATE